

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Masatoshi TAKAHASHI et al.

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Appln. No.: 10/521,553

For: SEMICONDUCTOR PROCESSING DEVICE AND IC CARD

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INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Attn: Mail Stop PCT, DO/EO/US

Sir:

Pursuant to 37 C.F.R. § 1.56, and without any
assertion as to materiality or prior art effect, the
documents listed on the attached Form PTO-1449 are hereby
cited.

Documents AE and AF on the attached List were cited in
the specification, on pages 1 and 2, and their relevance is
indicated therein.

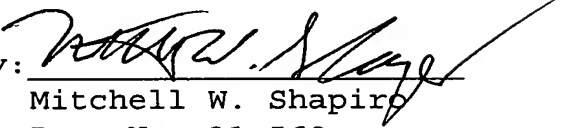
Documents AA-AC and AG-AP were cited in the
International Search Report in the underlying PCT
Application.

Respectfully submitted,

MWS:sjk

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By:


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October 26, 2005

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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT LIST OF DOCUMENTS CITED BY APPLICANT					Atty. Docket No. XA-10261		Appln. No. 10/521,553	
					Applicant Masatoshi TAKAHASHI et al.			
					Filing Date January 19, 2005		Group	
U.S. PATENT DOCUMENTS								
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date	
	AA	5,612,913	03/18/97	Cappelletti	365	185.12		
	AB	6,097,059	08/01/00	Yamada	257	321		
	AC	5,553,016	09/03/96	Takebuchi	365	51		
	AD	5,768,194	06/16/98	Matsubara et al.	365	185.33		
FOREIGN PATENT DOCUMENTS								
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation	
	AE	63-266698	02/11/88	Japan			Yes	
	AF	5-266219	10/15/93	Japan			Abstract	
	AG	10-198776	07/31/98	Japan			Abstract	
	AH	10-334205	12/18/98	Japan			Abstract	
	AI	2000-21183	01/21/00	Japan			Abstract	
	AJ	59-21058	02/02/84	Japan			Abstract	
	AK	2000-90676	03/31/00	Japan			Abstract	
	AL	7-326684	12/12/95	Japan			Abstract	
	AM	2-96378	04/09/90	Japan			Abstract	
	AN	4-364077	12/16/92	Japan			Abstract	
	AO	10-107231	04/24/98	Japan			Abstract	
	AP	3-126265	05/29/91	Japan			Abstract	
	AQ							
	AR							
	AS							
OTHER (including author, title, date, pertinent pages, etc.)								
	AT							
Examiner					Date Considered			
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.								